X20(c)AI1744-3

1 Selecting the description

This data sheet describes 2 module revisions. The module revision is laser-marked on the side of the module. Select the desired module revision from the following table to view its description.

Module	Revision	Page
X20AI1744-3	≥G0	2
X20cAl1744-3	All	
X20AI1744-3	<g0< td=""><td>29</td></g0<>	29

2 X20(c)Al1744-3 - Description for modules with Rev. G0 or later

2.1 General information

This module works with both 4-wire and 6-wire strain gauge load cells. The concept applied by the module requires compensation in the measurement system. This compensation eliminates the absolute uncertainty in the measurement circuit, such as component tolerances, effective bridge voltage or zero point offset. The measurement precision refers to the absolute (compensated) value, which will only change as a result of changes in the operating temperature.

- · 1 full-bridge strain gauge input
- Data output rate configurable from 0.1 Hz to 7.5 kHz
- · Special operating modes (synchronous mode and multiple sampling)
- · Configurable filter level

2.2 Coated modules

Coated modules are X20 modules with a protective coating for the electronics component. This coating protects X20c modules from condensation and corrosive gases.

The modules' electronics are fully compatible with the corresponding X20 modules.

For simplification purposes, only images and module IDs of uncoated modules are used in this data sheet.

The coating has been certified according to the following standards:

- · Condensation: BMW GS 95011-4, 2x 1 cycle
- · Corrosive gas: EN 60068-2-60, Method 4, exposure 21 days







2.3 Order data

Table 1: X20AI1744-3, X20cAI1744-3 - Order data

2.4 Technical data

Model number	X20AI1744-3	X20cAl1744-3
Short description		
I/O module	1 full-bridge str	rain gauge input
General information		
B&R ID code	0xA4EF	0xEB00
Status indicators	Channel status, operati	ng status, module status
Diagnostics		
Module run/error	Yes, using status	LED and software
Open circuit	Yes, using status	LED and software
Input	Yes, using status	LED and software
Power consumption		
Bus	0.0	1 W
Internal I/O	9.0	5 W
Additional power dissipation caused by the actua-	Max	+0.36 1)
tors (resistive) [W]		
Electrical isolation		
Bus - Analog input	Y	'es
Bus - Bridge supply voltage	Υ	´es
Channel - I/O power supply	N	No.
Certification		
CE	Υ	es es
KC	Yes	-
UL		E115267
		trol Equipment
ATEX	· ·	nA nC IIA T5 Gc
) - max. 60°C
GOST-R		TEX 0083X
*****	Y	'es
Full-bridge strain gauge	2 to 256 m)/// confic	gurable using software
Strain gauge factor		connections ²⁾
Connection		
Input type		te a full-bridge strain gauge bit
Digital converter resolution Conversion time		gured data output rate
Data output rate	· · · · · · · · · · · · · · · · · · ·	configurable using software (f _{DATA})
Input filter	0.1 - 7500 samples per second,	Configurable using software (IDATA)
		Hz
Cutoff frequency Order		3
Slope		dB
ADC filter characteristics		eristics of the sigma-delta A/D converter"
Operating range / Measurement sensor		5000 Ω
Influence of cable length		be as short as possible and run sepa-
initidefice of cable length	•	d circuit) without intermediate terminals
Input protection	• • •	otection
Common-mode range	·	3 VDC
		nge (with regard to the poten-
		e inputs "Input +" and "Input -"
Isolation voltage between input and bus	500) V _{Eff}
Conversion procedure	Sigma	a-delta
Output of the digital value		
Broken bridge supply line	Value app	proaches 0
Broken sensor line	Value approaches ±end value ("open circuit"	status bit is set in the Module status register)
Valid value range		FF (-8,388,607 to 8,388,607)
Strain gauge supply		· · · · · · · · · · · · · · · · · · ·
Voltage	5.5 VDC / I	max. 65 mA
Short circuit protection, overload protection		es
Voltage drop for short circuit protection		DC at 65 mA
O		

Table 2: X20AI1744-3, X20cAI1744-3 - Technical data

Model number	X20AI1744-3	X20cAl1744-3
Quantization 3)		
LSB value (16-bit)		
2 mV/V	336	nV
4 mV/V	671	nV
8 mV/V	1.343	3 μV
16 mV/V	2.686	θμV
32 mV/V	5.37	1 µV
64 mV/V	10.74	4 μV
128 mV/V	21.48	υ Β μV
256 mV/V	42.97	7 μV
LSB value (24-bit)		
2 mV/V	1.31	nV
4 mV/V	2.62	nV
8 mV/V	5.25	nV
16 mV/V	10.49	9 nV
32 mV/V	20.98	3 nV
64 mV/V	41.90	3 nV
128 mV/V	83.92	2 nV
256 mV/V	167.8	5 nV
Max. gain drift	12 ppn	n/°C ⁴⁾
Max. offset drift	2 ppm	√°C ⁵⁾
Nonlinearity	<10 p	pm ⁵⁾
Operating conditions		
Mounting orientation		
Horizontal	Ye	es
Vertical	Ye	es
Installation at elevations above sea level		
0 to 2000 m	No limit	tations
>2000 m	Reduction of ambient temper	erature by 0.5°C per 100 m
EN 60529 protection	IP2	20
Environmental conditions		
Temperature		
Operation		
Horizontal installation	-25 to	60°C
Vertical installation	-25 to	50°C
Derating	See section "Hardy	vare configuration"
Storage	-40 to	85°C
Transport	-40 to	85°C
Relative humidity		
Operation	5 to 95%, non-condensing	Up to 100%, condensing
Storage	5 to 95%, nor	n-condensing
Transport	5 to 95%, nor	n-condensing
Mechanical characteristics		
Note	Order 1x X20TB12 terminal block separately Order 1x X20BM11 bus module separately	Order 1x X20TB12 terminal block separately Order 1x X20cBM11 bus module separately
Spacing	12.5+0.	<u> </u>

Table 2: X20AI1744-3, X20cAI1744-3 - Technical data

- 1) Depends on the full-bridge strain gauge being used.
- 2) With 6-wire connections, line compensation does not function (see section "Connection examples").
- 3) Quantization depends on the strain gauge factor.
- 4) Based on the current measured value.
- 5) Based on the entire measurement range.

2.5 LED status indicators

For a description of the various operating modes, see section "Additional information - Diagnostic LEDs" of the X20 system user's manual.

Figure	LED	Color	Status	Description
	r	Green	Off	No power to module
			Single flash	RESET mode
			Double flash	BOOT mode (during firmware update) ¹⁾
			Blinking	PREOPERATIONAL mode
m r e			On	RUN mode
4 1 5	е	Red	Off	No power to module or everything OK
1744			On	Error or reset status
a b	1	Green	Off	Possible causes:
X20 AI				Open circuit
×				Sensor is disconnected
1000				Converter is busy
			On	Analog/digital converter running, value OK

1) Depending on the configuration, a firmware update can take up to several minutes.

2.6 Pinout

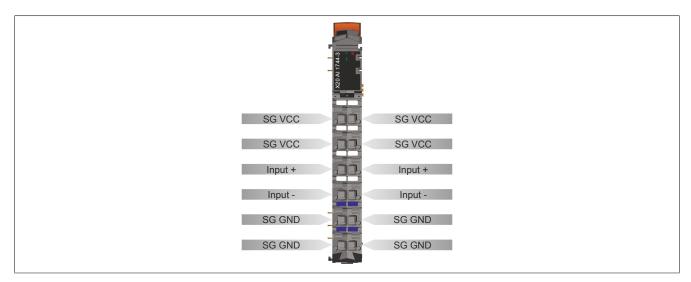
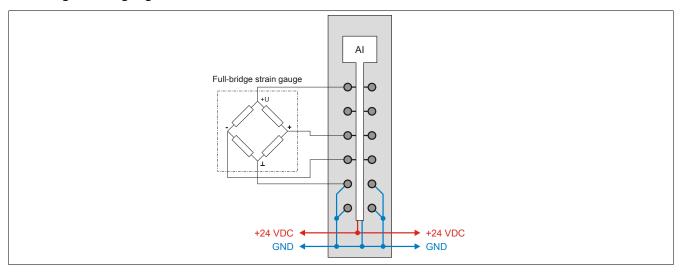


Figure 1: Pinout

2.7 Connection examples

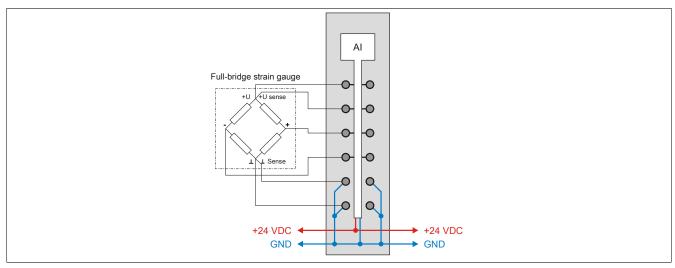
Full-bridge strain gauge with 4-wire connections



Full-bridge strain gauge with 6-wire connections

Full-bridge strain gauges can be connected to this module with 6-wire connections. Line compensation is not supported by the module, however. The sense lines are short circuited by the internally connected strain gauge VCC and GND connections (see section 2.8 "Input circuit diagram"). The measurement precision is therefore affected by changes in operating temperature. Longer cable lengths and smaller cable cross sections also increase the potential for errors in the measurement system.

In order to reduce cable resistance, the sense lines should be connected in parallel with the strain gauge supply lines. Optimal signal quality can be obtained by using a shielded twisted pair cable. The connections for the strain gauge supply lines, the sensor lines, and the bridge differential voltage lines should each use one twisted pair cable.



Parallel connection of 2 full-bridge strain gauges (4-wire connections)

If connecting the full-bridge strain gauges in parallel, the manufacturer's guidelines must be observed.

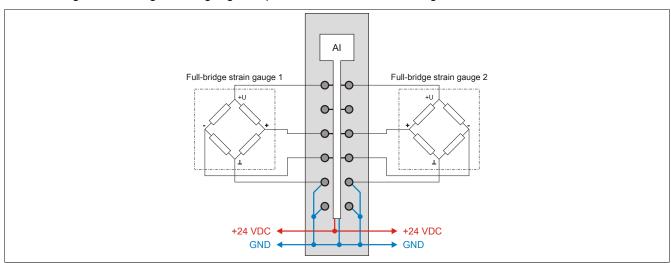
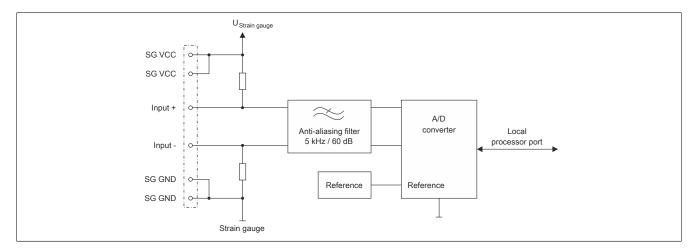


Figure 2: Connection example - Parallel connection of 2 full-bridge strain gauges

When connecting 3 or more full-bridge strain gauges in parallel, 2 lines must be connected together in an X20 terminal block.

2.8 Input circuit diagram

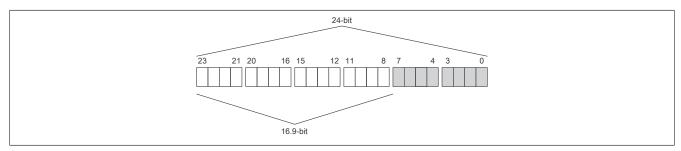


2.9 Effective resolution of the A/D converter

The A/D converter on the module provides a 24-bit measured value. The actual attainable noise-free resolution is always less than 24-bit, however. This "effective resolution" depends on the data rate and measurement range.

Example:

Based on the conversion method, a data rate of 2.5 Hz and a specified measurement range of 2 mV/V result in an effective resolution of 16.9 bits:



The low-order bits (grayed out) contain only noise instead of valid values and must therefore not be evaluated.

With "Function model 1 - Multiple sampling", only the highest 16 bits are made available.

2.10 Calculation example / Quantization

In a weighing application, the corresponding weight located on the connected load cell should be determined from the value derived from the module.

The characteristics of the strain gauge load cell are as follows:

Rated load: 1000 kgBridge factor: 4 mV/V

The value for the positive full-scale deflection at a specified rated load of 1000 kg is derived from the bridge factor of the strain gauge load cell (multiplication with the bridge supply voltage from the module):

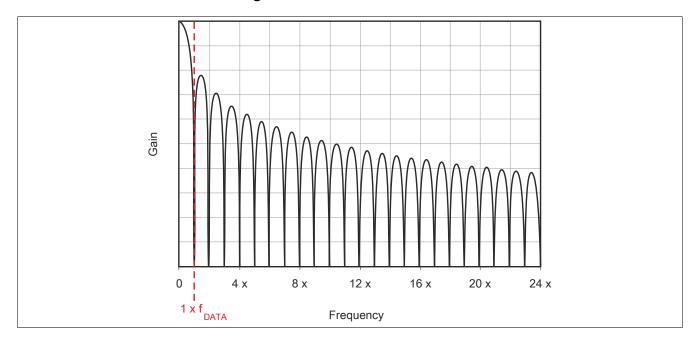
$4 \text{ mV/V} \times 5.5 \text{ V} = 22 \text{ mV}$

With a simple Rule of Three calculation, the corresponding value can be calculated (as seen in the table) from weight to the converter value and vice versa. This simplified theoretical approach is only valid for an ideal measurement system. Calibration of the entire measurement system is recommended because not only the module, but particularly the strain gauge bridges exhibit tolerances (offset, gain). When taring, the gradient offset is recalculated and the gain of the linear equation is determined when normalized. In addition to the calculation displayed in the table, these calculations must also be carried out in the application.

24-bit value	of the module	Quantization	Corresponding weight
0x007F FFFF	8,388,607	22.0 mV	1000 kg
0x0000 0001	1	2.62 nV	0.119 g
0x0000 20C3	8387	22.0 μV	1 kg
0x0001 0000	65536	171.9 μV	7.81 kg

The values for each LSB can be found in the technical data of the module under "Quantization" (1 LSB in reference to 16-bit and 1 LSB in reference to 24-bit).

2.11 Filter characteristics of the sigma-delta A/D converter

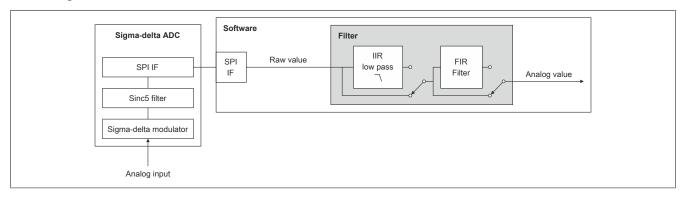


2.12 Software filters

2 filters are available for the analog input. They can be individually enabled and configured at runtime. By default, both filters are disabled when the device is switched on. The filters are controlled and configured using "Function model 2 - Extended filter".

In order to allow the filter behavior to be adapted to the measuring situation or machine cycle (high dynamics and low precision or low dynamics and high precision), the filter characteristics of both the IIR low-pass filter as well as the FIR filter can be changed synchronously at any time.

Filter diagram



2.12.1 IIR low-pass filter

2.12.1.1 General information

The IIR low-pass filter is used to generally smooth and increase the resolution of the analog value. The filter works according to the following formula:

$$y = y_{Old} + \frac{x - y_{Old}}{2^{Filter level}}$$

x ... Current filter input value

yold ... Old filter output value

y ... New filter output value

The "Filter level" parameter in the formula above is configured using the *ConfigCommonOutput01* register. "Filter level" = 0 if the IIR low-pass filter is disabled.

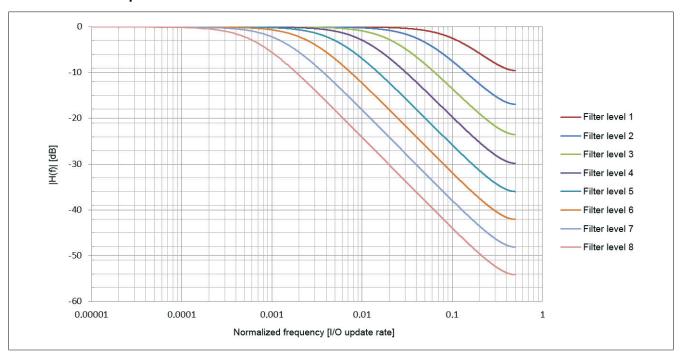
2.12.1.2 Filter characteristics of the 1st-order IIR low-pass filter

Limit frequency f_c

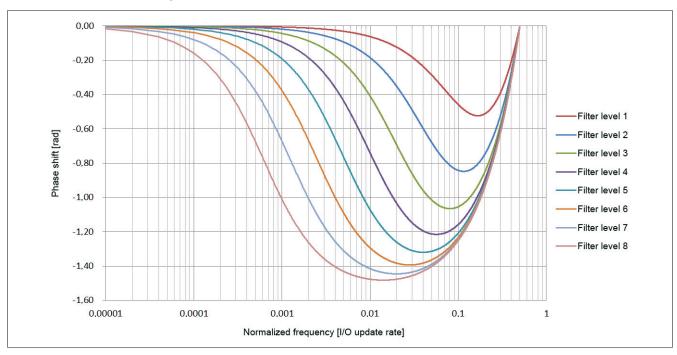
The following table provides an overview of the -3 dB limit frequency f_c depending on the configured filter level.

Filter level	Normalized f _c	f _c [Hz]	f _c [Hz]
	[I/O update rate]	I/O update rate = 15000/s	I/O update rate = 20000/s
1	0.11476	1721.4	2295.2
2	0.046	690	920
3	0.02124	318.6	424.8
4	0.01026	153.9	205.2
5	0.00504	75.6	100.8
6	0.0025	37.5	50
7	0.00124	18.6	24.8
8	0.00062	9.3	12.4

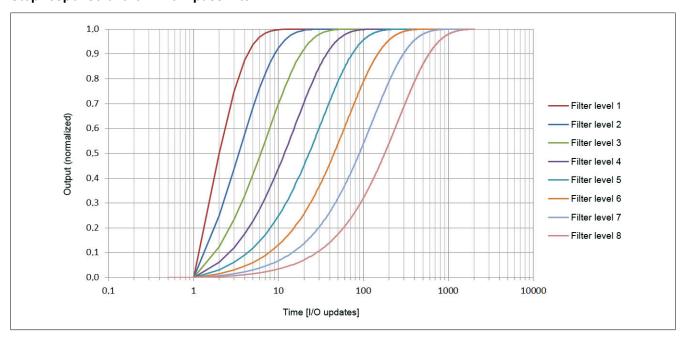
Gain of the IIR low-pass filter



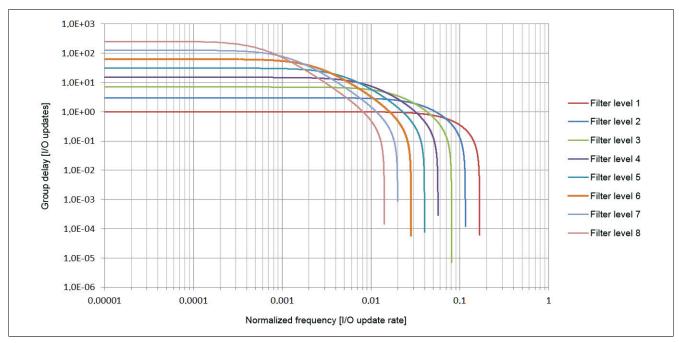
Phase shift of the IIR low-pass filter



Step response of the IIR low-pass filter



Group delay of the IIR low-pass filter



2.12.2 FIR filter

Like the IIR low-pass filter, the FIR filter can also be used to smooth out the signal and increase its resolution. In addition, configuring the filter length accordingly makes it possible to target and efficiently filter out individual interference frequencies. The source of these interference frequencies may be mechanical or electromagnetic. Multiples of these are also filtered out (as long as they are a whole-number factor of the data output rate).

Example:

Data output rate = 15000 samples/s, averaging over 15 values → "Notch" at 1 kHz (2 kHz, etc.)

When reconfiguring the filter, it takes 1/data rate (FIR filter in "Selectable data rate" mode) or 1/filter frequency (FIR filter in "High-resolution data rate" mode) until the filter is engaged. During engagement, bit 5 in the 2.14.8.1 "StatusInput01" register is set.

2.12.2.1 Characteristics of the FIR filter in "Selectable data rate" mode

The following table applies to "Function model 0 - Standard" and "Function model 254 - Bus controller" as well as for "Function model 2 - Extended filter" in "Selectable data rate" mode.

			I/O updat	te rate [Hz]	I/O updat	e time [ms]
Set value	Data rate (f _{Data}) [Hz] ^{3) 4)}	f _{Notch} [Hz]	Function model 0 and 254	Function model 2 ("Selectable da- ta rate" mode)	Function model 0 and 254	Function model 2 ("Selectable da- ta rate" mode)
0000	2.5	2.5	2.5	15000	400	0.0667
0001	5	5	5	15000	200	0.0667
0010	10	10	10	15000	100	0.0667
0011	15	15	15	15000	66.6667	0.0667
0100	25	25	25	15000	40	0.0667
0101	30	30	30	15000	33.3333	0.0667
0110	50	50	50	15000	20	0.0667
0111	60	60	60	15000	16.6667	0.0667
1000	100	100	100	15000	10	0.0667
1001	500	500	500	15000	2	0.0667
1010	1000	1000	1000	15000	1	0.0667
1011	2000	2000	2000	20000	0.5	0.05
1100	3750	3750	3750	15000	0.2667	0.0667
1101	7500	7500	7500	15000	0.1333	0.0667
1110			Reser	ved		
1111			Reser	ved		

¹⁾ Function models 0 and 254: Bit 0 to 3 of register ConfigOutput01

²⁾ Function model 2: Bit 0 to 3 of register ConfigDatarateOutput01

³⁾ Function models 0 and 254: Data rate = 1/filter length [s] (f_{Notch}) = I/O update rate

⁴⁾ Function model 2: Data rate = 1/filter length [s] (f_{Notch})

2.12.2.2 Characteristics of the FIR filter in "High-resolution data rate" mode

The following table applies to "Function model 2 - Extended filter".

Set value [0.1 Hz] 1)	Data rate (f _{Data}) [Hz]	f _{Notch} [Hz]	I/O update time [μs]
1 to 65535	Set value / 10	= Data rate	≈50 µs ²)

- 1) Set value of register ConfigHighResolutionOutput01
- 2) The value varies between 42 and 56 μs (see also the next section "I/O update time")

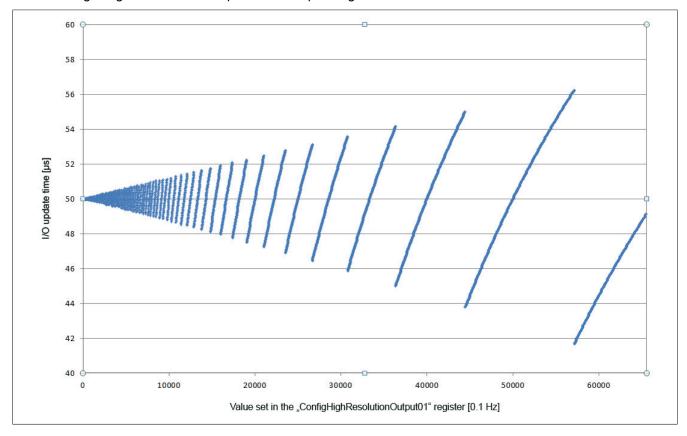
I/O update time

The value of the I/O update time depends on the set value and varies between 42 and 56 μ s. The following formula can be used to precisely calculate the I/O update time:

I/O update time = 1e6 * (1e-5 - 10 / (Set value * [10 / (5e-6 * Set value)]))

Key: The square brackets in the formula above mean that the calculated value must be rounded to a whole number.

The following image shows the I/O update time depending on the set value:

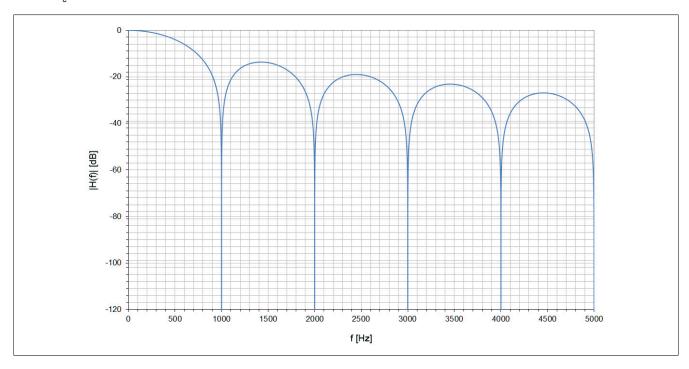


2.12.2.3 Examples for the gain of the FIR filter

Example 1

Filter setting = 10:

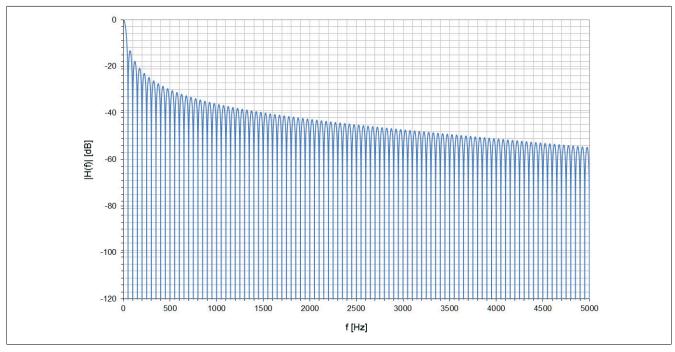
- $f_{Notch} = 1000 \text{ Hz}$
- $f_c = 439.3 \text{ Hz}$



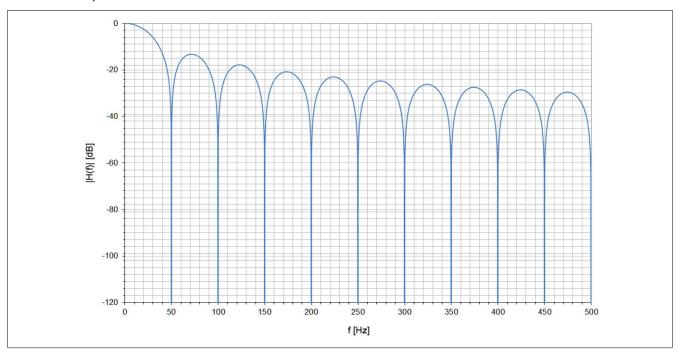
Example 2

Filter setting = 6:

- f_{Notch} = 50 Hz
- $f_c = 21.8 \text{ Hz}$



Detailed excerpt from the filter curve shown above:

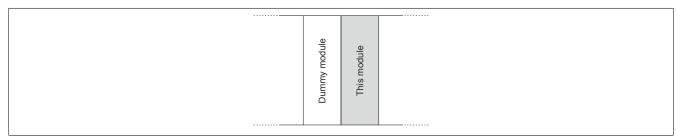


2.13 Hardware configuration

2.13.1 Hardware configuration for horizontal installation at 55°C ambient temperature

Operating a strain gauge module

At an ambient temperature of 55°C or higher, a dummy module must be connected to the left of the strain gauge module if installed horizontally.



Operating multiple strain gauge modules side by side

If 2 or more horizontal strain gauge modules are being operated in a cluster, the following arrangement of modules must be observed.

 Dummy module	This module	Dummy module	This module	Dummy module	This module	

2.13.2 Hardware configuration for vertical installation at 45°C ambient temperature

Operating a strain gauge module

At an ambient temperature of 45° C or higher, a dummy module must be connected to the left of the strain gauge module if installed vertically.

This module
Dummy module

Operating multiple strain gauge modules side by side

If 2 or more vertical strain gauge modules are being operated in a cluster, the following arrangement of modules must be observed.

1401 50 05001 404.		
	This module	
	Dummy module	
	This module	
	Dummy module	
	This module	
	Dummy module	

2.14 Register description

2.14.1 General data points

In addition to the registers listed in the register description, the module also has other more general data points. These registers are not specific to the module but contain general information such as serial number and hardware version.

These general data points are listed in section "Additional information - General data points" of the X20 system user's manual.

2.14.2 Function model 0 - Standard

Register	Name	Data type	Read		Write	
			Cyclic	Acyclic	Cyclic	Acyclic
2	StatusInput01	USINT	•			
4	AnalogInput01	DINT	•			
16	ConfigOutput01	USINT			•	
18	ConfigCycletime01	UINT				•
32	AdcClkFreqShift01	USINT				•

2.14.3 Function model 1 - Multiple sampling

In this function model, the A/D converter is operated synchronously to X2X Link with a predefined A/D converter cycle time. The value is configurable as 50 or 100 μ s.

The module returns between 3 and 10 measured values per X2X cycle depending on the configuration. With an X2X cycle time of 400 µs and A/D converter cycle time of 50 µs, exactly 8 measurements are performed and the module can return 8 values (strain gauge value 01 to strain gauge value 08).

If a longer cycle time is used, the values returned correspond to the last measurements. If using an X2X cycle time that is not a whole number multiple of the A/D converter cycle time, then the conversion cannot be synchronized with X2X Link. In this case, the module outputs the invalid value 0x8000.

Example 1

If using an X2X cycle time of 800 μ s, it is possible to perform 16 measurements per X2X cycle if the A/D converter cycle time equals 50 μ s. The first 6 measured values are discarded; the last 10 measured values are provided by the module.

With a shorter X2X cycle time, the number of measured values should not exceed the number of measurements that can actually be made. All other measured values are invalid (0x8000). To minimize the load on X2X Link, it is possible to disable unneeded registers (see "Number of measured values").

Example 2

If using an X2X cycle time of 300 μ s, it is possible to perform 6 measurements per X2X cycle if the A/D converter cycle time equals 50 μ s. For this reason, only the first 6 registers are valid. The registers for the 7th through 10th measured value (AnalogInput07 to AnalogInput10) should be disabled by setting "Number of measured values" to "6 measured values" in the I/O configuration.

Register	Name	Data type	Read		Write	
			Cyclic	Acyclic	Cyclic	Acyclic
2	StatusInput01	USINT	•			
1534 + N * 4	AnalogInput0N (N = 1 to 10)	INT	•			
1601	ConfigGain01_MultiSample	USINT			•	
1603	ConfigCycletime01_MultiSample	USINT				•

2.14.4 Function model 2 - Extended filter

This function model allows the IIR low-pass filter and the FIR filter to be enabled.

Register	Name	Data type	Read		Write	
			Cyclic	Acyclic	Cyclic	Acyclic
2	StatusInput01	USINT	•			
4	AnalogInput01	DINT	•			
256	AdcConvTimeStampInput01	DINT	•			
272	ConfigCommonOutput01	USINT			•	
288	ConfigFilterOutput01	UINT				•
273	ConfigDatarateOutput01	USINT			•	
274	ConfigHighResolutionOutput01	UINT			•	

2.14.5 Function model 254 - Bus controller

In the "254 - Bus controller" function model, the module behaves as it does in "Function model 0 - Standard", with the exception that it is not synchronized to X2X Link even if synchronous mode is activated in register 2.14.6.3 "ConfigOutput01". Instead, the module behaves as if the set A/D converter cycle time is not a factor or multiple of the X2X cycle time and attempts to maintain the set A/D converter cycle time as precisely as possible.

Register	Name	Data type	Read		Write	
			Cyclic	Acyclic	Cyclic	Acyclic
2	StatusInput01	USINT	•			
4	AnalogInput01	DINT	•			
16	ConfigOutput01	USINT			•	
18	ConfigCycletime01	UINT				•
32	AdcClkFreqShift01	USINT				•

2.14.6 Register for the "0 - Standard" and "254 - Bus controller" function models

2.14.6.1 Module status

Name:

StatusInput01

The current state of the module is indicated in this register.

Data type	Value
USINT	See bit structure.

Bit structure:

Bit	Description	Value	Information
0	A/D converter value	0	Valid A/D converter value
		1	Invalid A/D converter value
1	Line monitoring	0	OK
		1	Open circuit
2	Only valid in synchronous mode	0	A/D converter runs synchronous to X2X Link
		1	A/D converter does not run synchronous to X2X Link
3 - 7	Reserved	-	

2.14.6.2 Strain gauge value

Name:

AnalogInput01

This register contains the raw value determined by the A/D converter for the full-bridge strain gauge with 24-bit resolution.

Data type	Value	Information
DINT	0xFF800001 to 0x007FFFFF	Valid range of values
	0x007FFFF	Overflow
	0xFF800001	Underflow
	0xFF800000	Invalid value

Effective resolution

In principle, the effective resolution of the A/D converter is dependent on the data rate and the measurement range (see 2.9 "Effective resolution of the A/D converter").

The following table shows how the effective resolution (in bits), or the RMS value range of the strain gauge value depend on the module configuration (data rate, measurement area).

				Measure	ment range			
	±16	mV/V	±8 :	mV/V	±4 i	mV/V	±	2 mV/V
Data rate f _{DATA} [Hz]	Bits	Range of values	Bits	Range of values	Bits	Range of values	Bits	Range of values
2.5	19.8	±456,000	18.9	±245,000	17.9	±122,000	16.7	±53,000
5	19.2	±301,000	18.4	±173,000	17.2	±75,000	16	±33,000
10	18.6	±199,000	17.8	±114,000	16.6	±50,000	15.6	±25,000
15	18.4	±173,000	17.4	±86,000	16.2	±38,000	15.4	±22,000
25	18	±131,000	17.1	±70,000	15.7	±27,000	14.9	±15,000
30	17.7	±106,000	16.7	±53,000	16	±33,000	15.1	±18,000
50	17.5	±93,000	16.6	±50,000	15.6	±25,000	14.4	±11,000
60	17.5	±93,000	16.6	±50,000	15.6	±25,000	14.5	±12,000
100	17.2	±75,000	16.3	±40,000	15.2	±19,000	14.5	±12,000
500	16.6	±50,000	15.7	±27,000	14.6	±12,000	13.5	±6,000
1000	16.2	±38,000	15.4	±22,000	14.2	±9,000	13.4	±5,000
2000	15.7	±27,000	14.9	±15,000	13.9	±8,000	12.9	±4,000
3750	15.5	±23,000	14.7	±13,000	13.7	±7,000	12.6	±3,000
7500	15.2	±19,000	14.5	±12,000	13.4	±5,000	12.5	±3,000

Table 3: Effective resolution of the strain gauge value in bits for the measurement range 2 to 16 mV/V

				Measurer	nent range			
	±256	6 mV/V	±128	mV/V	±64	±64 mV/V		2 mV/V
Data rate f _{DATA} [Hz]	Bits	Range of values	Bits	Range of values	Bits	Range of values	Bits	Range of values
2.5	22.4	±2,767,000	22	±2,097,000	21.4	±1,384,000	20.7	±852,000
5	22	±2,097,000	21.7	±1,703,000	21	±1,049,000	19.9	±489,000
10	21	±1,049,000	20.7	±852,000	20.5	±741,000	19.2	±301,000
15	20.8	±913,000	20.5	±741,000	20.3	±645,000	19.2	±301,000
25	20.3	±645,000	20.1	±562,000	19.8	±456,000	18.9	±245,000
30	20.3	±645,000	19.9	±489,000	19.7	±426,000	18.8	±228,000
50	19.9	±489,000	19.5	±371,000	19.4	±346,000	18.6	±199,000
60	19.4	±346,000	19.2	±301,000	19.1	±281,000	18.3	±161,000
100	19.1	±281,000	19	±262,000	19	±262,000	18.1	±140,000
500	17.9	±122,000	17.8	±114,000	17.7	±106,000	17.3	±81,000
1000	17.5	±93,000	17.4	±86,000	17.3	±81,000	17	±66,000
2000	17	±66,000	16.7	±53,000	16.7	±53,000	16.4	±43,000
3750	16.4	±43,000	16.4	±43,000	16.4	±43,000	16	±33,000
7500	16.1	±35,000	16.1	±35,000	15.9	±31,000	15.7	±27,000

Table 4: Effective resolution of the strain gauge value in bits for the measurement range 32 to 256 mV/V

2.14.6.3 A/D converter configuration

Name:

ConfigOutput01

The data rate and measurement range of the A/D converter can be configured in this register.

Data type	Value
USINT	See bit structure.

Bit structure:

Bit	Description	Value	Information
0 - 3	Data rate f _{DATA} (samples per second):	0000	2.5
		0001	5
		0010	10
		0011	15
		0100	25
		0101	30
		0110	50
		0111	60
		1000	100
		1001	500
		1010	1000
		1011	2000
		1100	3750
		1101	7500
		1110	Synchronous mode
		1111	Reserved
4 - 6	Standard measurement range (bit 6 = 0)	000	16 mV/V
		001	8 mV/V
		010	4 mV/V
		011	2 mV/V
	Extended measurement range (bit 6 = 1)	100	256 mV/V
		101	128 mV/V
		110	64 mV/V
		111	32 mV/V
7	Reserved	0	(must be 0)

2.14.6.3.1 Synchronous mode

The analog/digital converter (A/D converter) can optionally be operated and read synchronously to X2X Link. Synchronous mode is enabled by selecting the respective operating mode in register *ConfigOutput01*. A time between 200 and 2000 µs must also be set in register *ConfigCycletime01*. If this time is a whole number factor or multiple of the configured cycle time of X2X Link, then the A/D converter is read synchronously to X2X Link.

Information:

The A/D converter cycle time must be ≥1/4 of the X2X cycle time!

Bit 2 in *Module status* is set (i.e. A/D converter not running synchronously)...

- ... If the configured A/D converter cycle time cannot be synchronized with X2X Link.
- · ... If the module is still in the settling phase.

Jitter, dead time and settling time:

Jitter	
A/D converter cycle times <1500 μs	Max. ±1 µs
A/D converter cycle times >1500 μs	Max. ±4 µs
X2X link dead time	50 μs + ^{X2X cycle time} 128
Settling time	150 x X2X cycle time

The settling time corresponds to the time needed until the A/D converter can be operated after enabling synchronous mode or following conversion of the A/D converter cycle time.

2.14.6.4 A/D converter cycle time

Name:

ConfigCycletime01

This register is only used in "Synchronous mode". If synchronous mode is enabled in the A/D converter configuration, then the module attempts to operate the A/D converter as synchronously as possible to X2X Link (based on the A/D converter cycle time set in this register). It is of course necessary for the X2X Link cycle time and the A/D converter cycle time to have a certain ratio. The following conditions must be observed:

- 1 A/D converter cycle time ≥ 1/4 X2X cycle time
- 2 A/D converter cycle time corresponds to a whole number factor or multiple of the X2X cycle time
- 3 A/D converter cycle time must be in the range 50 to 2000 μ s

Data type	Value
UINT	50 to 2000

2.14.6.5 A/D converter clock frequency shift

Name:

AdcClkFreqShift01

In rare cases, strain gauge modules connected to neighboring slots can influence one another. This can result in temporary, minimal deviations in measured values. This can only occur if the sigma-delta A/D converters on the neighboring strain gauge modules are operated at exactly the same clock frequency.

In most cases, these clock frequencies vary slightly due to part variances. When they are the same however, this register on the strain gauge module provides a safe way for an application to prevent this type of mutual influence.

Data type	Value
SINT	-128 to 127

This register can be used to vary the clock frequency in increments of 200 ppm. Setting values from -50 to 50 cover a range of -10000 ppm to 10000 ppm. This corresponds with -1% to 1%.

Values beyond this range will cause activation of a default mode. The frequency shift is derived from the last 2 digits of the serial number by the module firmware. This saves time that would otherwise be needed for programming, provided that the last two digits of the serial numbers on the neighboring modules are not the same

Register value	Frequency shift in ppm	Example of a sampling rate ¹⁾
127	((SerialNo. modulo 100) - 50) * (-200) ppm	Based on the serial number
51	((SerialNo. modulo 100) - 50) * (-200) ppm	Based on the serial number
50	10000	505
49	9800	504.9
2	400	500.2
1	200	500.1
0	0	500
-1	-200	499.9
-2	-400	499.8
-50	-10000	495
-51	((SerialNo. modulo 100) - 50) * (-200) ppm	Based on the serial number
-128	((SerialNo. modulo 100) - 50) * (-200) ppm	Based on the serial number

¹⁾ Nominal sampling rate of 500 samples per second

Important:

As shown in the table above, shifting the A/D converter clock frequency will equally shift the A/D converter sampling rate. Shifting the A/D converter clock frequency too much can cause problems with disturbance suppression particularly when a very specific sampling rate has been defined to suppress existing disturbances (e.g. 50 Hz to suppress the 50 Hz hum). See also 2.11 "Filter characteristics of the sigma-delta A/D converter".

It's situations like this where the option to manually shift the frequency in the I/O configuration or ASIOACC library should be utilized rather than relying on the default frequency shift that is based on the serial number.

A frequency shift like the one shown below would be sufficient to prevent modules from influencing one another and would not cause any noticeable difference to the filter characteristics.

Slot	1	2	3	4	5	6	
A/D converter clock frequency shift	0	2	-1	1	-2	0	

Information:

- This register has no effect in synchronous mode because the firmware regulates the A/D converter clock frequency in such a way that the A/D converter cycle is synchronous with the X2X cycle.
- When writing to this register using the ASIOACC library, only the lowest value byte of the written value is accepted. For example, the value 256 (=0x100) is identical to the value 0 (=0x00).

2.14.7 Register for "Function model 1 - Multiple sampling"

2.14.7.1 Module status

Name:

StatusInput01

The current state of the module is indicated in this register.

Data type	Value
USINT	See bit structure.

Bit structure:

Bit	Description	Value	Information
0	A/D converter values	0	Valid A/D converter value
		1	Invalid A/D converter value
1	Line monitoring	0	OK
		1	Open circuit An open circuit was found during at least one measurement in this X2X cycle. This bit is reset if all measurements are OK after correcting this error, i.e. it does not have to be acknowledged.
2	Synchronous mode	0	A/D converter runs synchronous to X2X Link
		1	A/D converter does not run synchronous to X2X Link
3 - 7	Reserved	-	

2.14.7.2 Strain gauge value - Multiple

Name:

AnalogInput01 to AnalogInput10

This register contains the raw value determined by the A/D converter for the full-bridge strain gauge with 16-bit resolution. The module returns between 3 and 10 measured values per X2X cycle depending on the configuration.

Effective resolution

In principle, the effective resolution of the A/D converter is dependent on the data rate and the measurement range (see 2.9 "Effective resolution of the A/D converter").

The following table shows how the effective resolution (in bits), or the RMS value range of the strain gauge value depend on the module configuration (data rate, measurement area).

	Measurement range							
±16	±16 mV/V ±8 mV/V			±4 n	ηV/V	±2 n	nV/V	
Bits	Range of values	Bits	Range of values	Bits	Range of values	Bits	Range of values	
15.4	22,000	14.6	12,000	13.8	7,000	12.8	4,000	

Table 5: Effective resolution of the strain gauge value in bits for the measurement range 2 to 16 mV/V

	Measurement range							
±256 mV/V		±128	±128 mV/V		±64 mV/V		±32 mV/V	
Bits	Range of values	Bits	Range of values	Bits	Range of values	Bits	Range of values	
17.1	70,000	16.7	53,000	16.4	43,000	15.9	31,000	

Table 6: Effective resolution of the strain gauge value in bits for the measurement range 32 to 256 mV/V

2.14.7.3 A/D converter configuration

Name:

ConfigGain01_MultiSample

The measurement range for the A/D converter can be configured in this register.

Data type	Value
USINT	See bit structure.

Bit structure:

Bit	Description	Value	Information
0 - 2	Standard measurement range (bit 2 = 0)	000	16 mV/V
		001	8 mV/V
		010	4 mV/V
		011	2 mV/V
	Extended measurement range (bit 2 = 1)	100	256 mV/V
		101	128 mV/V
		110	64 mV/V
		111	32 mV/V
3 - 7	Reserved	0	(must be 0)

2.14.7.4 A/D converter cycle time

Name:

ConfigCycletime01_MultiSample

The A/D converter cycle time can be configured in this register.

In order for multiple sampling to work, the X2X cycle time must be divisible by the A/D converter cycle time (i.e. result in a whole number).

Data type	Value	Information
USINT	0	50 μs (default)
	1	100 μs
	2 to 255	Reserved

2.14.7.5 Number of measured values

If the X2X cycle time is too short, then bot all 10 measurements can be performed. To reduce the load on X2X Link, it makes sense to only transfer as many values as measurements that can be made. This is why it is possible to configure the number of measured values to be transferred (see 2.14.3 "Function model 1 - Multiple sampling").

Example: A/D converter cycle time 50 µs

X2X cycle time	Number of measured values to be transferred
250 μs	5
300 µs	6
350 µs	7
400 μs	8
450 µs	9
≥500 µs	10

Example: A/D converter cycle time 100 µs

X2X cycle time	Number of measured values to be transferred
300 µs	3
400 μs	4
500 μs	5
600 µs	6
700 µs	7
800 µs	8
900 µs	9
≥1 ms	10

2.14.8 Register for "Function model 2 - Extended filter"

2.14.8.1 Module status

Name:

StatusInput01

The current state of the module is indicated in this register. If there is a fault in the module power supply or strain gauge supply, the analog input value indicates an invalid range and the buffer of the enabled filter is reset.

Data type	Value
USINT	See bit structure.

Bit structure:

Bit	Description	Value	Information
0	0 A/D converter values	0	ADC value is valid
		1	ADC value is invalid
1	Line monitoring	0	OK
		1	Open circuit
2	Reserved	-	
3	Module power supply	0	OK
		1	Error in module power supply
4	Strain gauge supply	0	OK
		1	Error in strain gauge supply
5	FIR filter ready	0	OK
		1	FIR filter not yet ready
6 - 7	Reserved	-	

2.14.8.2 A/D converter conversion timestamp

Name:

AdcConvTimeStampInput01

This register holds the timestamp of the last analog conversion. This is always the point in time (in μ s) at which the conversion of the latest A/D converter raw value is completed.

Data type	Value	Function
DINT	-2,147,483,648 to 2,147,483,647	Timestamp [µs] of the last analog conversion

2.14.8.3 A/D converter configuration and IIR filter configuration

Name:

ConfigCommonOutput01

The IIR low-pass filter and measurement range of the A/D converter can be configured in this register.

Data type	Value
USINT	See bit structure.

Bit structure:

Bit	Description	Value	Information
			Filter level
0 - 3	IIR low-pass filter	0000	0: IIR low-pass filter switched off
		0001	1
		0010	2
		0011	3
		0100	4
		0101	5
		0110	6
		0111	7
		1000	8
		1001 - 1111	The analog input value indicates an invalid range.
4 - 6	Default measurement range	000	16 mV/V
		001	8 mV/V
		010	4 mV/V
		011	2 mV/V
	Extended measurement range	100	256 mV/V
		101	128 mV/V
		110	64 mV/V
		111	32 mV/V
7	Reserved	0	(must be 0)

2.14.8.4 Data rate configuration

Name:

ConfigFilterOutput01

Whether a selectable data rate or a high-resolution data rate is being used for the FIR filter is configured in this register.

Data type	Value	Information
UINT	0	"Selectable data rate" mode:
		A selectable data rate is used for the FIR filter (default). Configuration takes place in register
		ConfigDatarateOutput01.
	1	"High-resolution data rate" mode:
		A high-resolution data rate is used for the FIR filter. Configuration takes place in register Con-
		figHighResolutionOutput01

Name:

ConfigDatarateOutput01

The data rate of the FIR filter in "Selectable data rate" mode is configured in this register.

Data type	Value
USINT	See bit structure.

Bit structure:

Bit	Description	Value	Information
0 - 3	Data rate f _{DATA} (samples per second):	0000	2.5
		0001	5
		0010	10
		0011	15
		0100	25
		0101	30
		0110	50
		0111	60
		1000	100
		1001	500
		1010	1000
		1011	2000
		1100	3750
		1101	7500
		1110 - 1111	The analog input value indicates an invalid range.
4 - 7	Reserved	0	(must be 0)

Name:

ConfigHighResolutionOutput01

The data rate of the FIR filter in 0.1 Hz steps is configured in this register (0.1 to 6553.5 Hz).

Data type	Value	Information
UINT	0	Disables the FIR filter
	1 to 65,535	0.1 to 6553.5 Hz

2.14.9 Minimum cycle time

The minimum cycle time defines how far the bus cycle can be reduced without communication errors occurring. Note that very fast cycles decrease the idle time available for handling monitoring, diagnostics and acyclic commands.

Minimum cycle time	
250 μs	

2.14.10 Minimum I/O update time

The minimum I/O update time defines how far the bus cycle can be reduced while still allowing an I/O update to take place in each cycle.

The I/O update times for the "0 - Standard", "2 - Extended filter" and "254 - Bus controller" function models are listed in section 2.12.2.1 "Characteristics of the FIR filter in "Selectable data rate" mode".

Depending on the setting in register *ConfigCycletime01*, the I/O update time in function model "1 - Multiple sampling" is 50 or 100 µs.

3 X20Al1744-3 - Description for modules with Rev. <G0

3.1 General information

This module works with both 4-wire and 6-wire strain gauge load cells. The concept applied by the module requires compensation in the measurement system. This compensation eliminates the absolute uncertainty in the measurement circuit, such as component tolerances, effective bridge voltage or zero point offset. The measurement precision refers to the absolute (compensated) value, which will only change as a result of changes in the operating temperature.

- · 1 full-bridge strain gauge input
- Data output rate configurable from 2.5 Hz to 7.5 kHz
- Special operating modes (synchronous mode and multiple sampling)

3.2 Order data

Model number	Short description	Figure
	Analog inputs	
X20AI1744-3	X20 analog input module,1 full-bridge strain gauge input,24-bit converter resolution,5 Hz input filter	3 d
	Required accessories	
	Bus modules	
X20BM11	X20 bus module, 24 VDC keyed, internal I/O power supply con-	X20
	tinuous	1=
	Terminal blocks	
X20TB12	X20 terminal block, 12-pin, 24 VDC keyed	

Table 7: X20Al1744-3 - Order data

3.3 Technical data

Model number	X20Al1744-3
Short description	
I/O module	1 full-bridge strain gauge input
General information	
B&R ID code	0xA4EF
Status indicators	Channel status, operating status, module status
Diagnostics	
Module run/error	Yes, using status LED and software
Open circuit	Yes, using status LED and software
Input	Yes, using status LED and software
Power consumption	
Bus	0.01 W
Internal I/O	1.25 W
Additional power dissipation caused by the actuators (resistive) [W]	Max. +0.36 ¹⁾
Electrical isolation	
Bus - Analog input	Yes
Bus - Bridge supply voltage	Yes
Channel - I/O power supply	No
Certification	
CE	Yes
KC	Yes
UL	cULus E115267 Industrial Control Equipment
ATEX	Zone 2, II 3G Ex nA nC IIA T5 Gc IP20, Ta = 0 - max. 60°C FTZÚ 09 ATEX 0083X
GOST-R	Yes
Full-bridge strain gauge	
Strain gauge factor	2 to 256 mV/V, configurable using software
Connection	4- or 6-wire connections 2)
Input type	Differential, used to evaluate a full-bridge strain gauge

Table 8: X20Al1744-3 - Technical data

X20Al1744-3
24-bit
Depends on the configured data output rate
2.5 - 7500 samples per second, configurable using software (f _{DATA})
1 1 , 3 3 (3)
5 Hz
3
60 dB
Sigma-delta, see section "Filter characteristics of the sigma-delta A/D converter"
85 to 5000 Ω
The shielded twisted pair cable should be as short as possible and run sepa-
rately to the sensor (isolated from load circuit) without intermediate terminals
RC protection
0 to 3 VDC
Permissible input voltage range (with regard to the poten-
tial strain gauge GND) on the inputs "Input +" and "Input -"
500 V _{Eff}
Sigma-delta
• • • • • •
Value approaches 0
Value approaches ±end value ("open circuit" status bit is set in the <i>Module status</i> register)
0xFF800001 to 0x007FFFFF (-8,388,607 to 8,388,607)
0.000001 to 0.000111111 (-0,000,001 to 0,000,001)
5.5 VDC / max. 65 mA ³⁾
Yes
Yes Max. 0.2 VDC at 65 mA
Max. U.2 VDC at 65 mA
336 nV
671 nV
1.343 μV
2.686 μV
5.371 μV
10.74 μV
21.48 μV
42.97 μV
1.31 nV
2.62 nV
5.25 nV
10.49 nV
20.98 nV
41.96 nV
83.92 nV
167.85 nV
10 ppm/°C
30 ppm/°C
ου μριια Ο
Yes
Yes
IG2
No limitations
No limitations
Reduction of ambient temperature by 0.5°C per 100 m
IP20
0 to 55°C
0 to 50°C
<u>-</u>
-25 to 70°C

Table 8: X20Al1744-3 - Technical data

Model number	X20Al1744-3					
Relative humidity						
Operation	5 to 95%, non-condensing					
Storage	5 to 95%, non-condensing					
Transport	5 to 95%, non-condensing					
Mechanical characteristics						
Note	Order 1x X20TB12 terminal block separately					
	Order 1x X20BM11 bus module separately					
Spacing	12.5 ^{+0.2} mm					

Table 8: X20AI1744-3 - Technical data

- 1) Depends on the full-bridge strain gauge being used.
- 2) With 6-wire connections, line compensation does not function (see section "Connection examples").
- 3) The maximum current of 90 mA is permitted up to an operating temperature of 45°C.
- 4) Quantization depends on the strain gauge factor.

3.4 LED status indicators

For a description of the various operating modes, see section "Additional information - Diagnostic LEDs" of the X20 system user's manual.

Figure	LED	Color	Status	Description	
	r	Green	Off	No power to module	
			Single flash	RESET mode	
4 1			Double flash	BOOT mode (during firmware update) ¹⁾	
			Blinking	PREOPERATIONAL mode	
			On	RUN mode	
	е	Red	Off	No power to module or everything OK	
1744			On	Error or reset status	
	1	Green	Off	Possible causes:	
X20 AI				Open circuit	
×				Sensor is disconnected	
The second second	ř l			Converter is busy	
			On	Analog/digital converter running, value OK	

¹⁾ Depending on the configuration, a firmware update can take up to several minutes.

3.5 Pinout

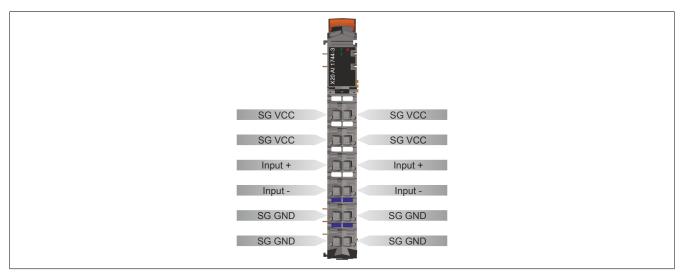
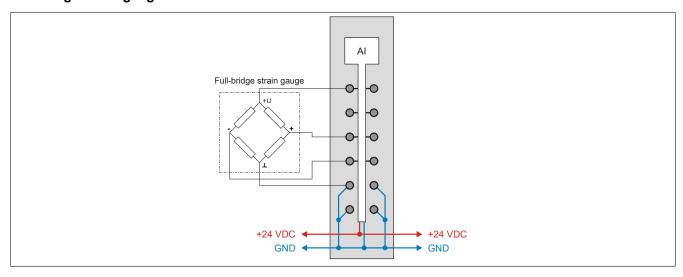


Figure 3: Pinout

3.6 Connection examples

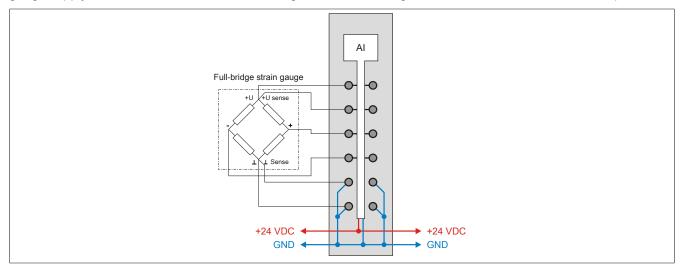
Full-bridge strain gauge with 4-wire connections



Full-bridge strain gauge with 6-wire connections

Full-bridge strain gauges can be connected to this module with 6-wire connections. Line compensation is not supported by the module, however. The sense lines are short circuited by the internally connected strain gauge VCC and GND connections (see section 3.7 "Input circuit diagram"). The measurement precision is therefore affected by changes in operating temperature. Longer cable lengths and smaller cable cross sections also increase the potential for errors in the measurement system.

In order to reduce cable resistance, the sense lines should be connected in parallel with the strain gauge supply lines. Optimal signal quality can be obtained by using a shielded twisted pair cable. The connections for the strain gauge supply lines, the sensor lines, and the bridge differential voltage lines should each use one twisted pair cable.



Parallel connection of 2 full-bridge strain gauges (4-wire connections)

If connecting the full-bridge strain gauges in parallel, the manufacturer's guidelines must be observed.

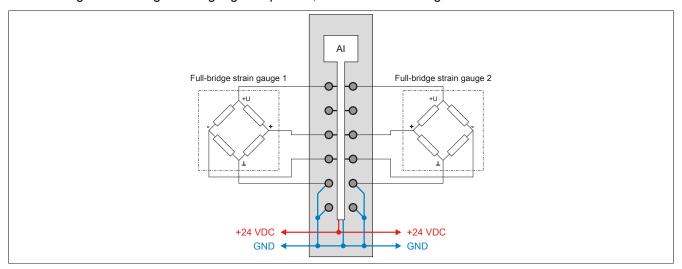
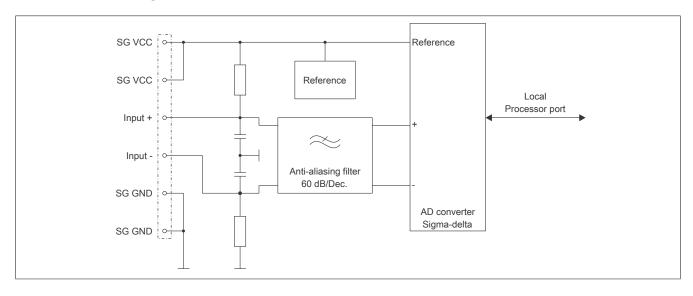


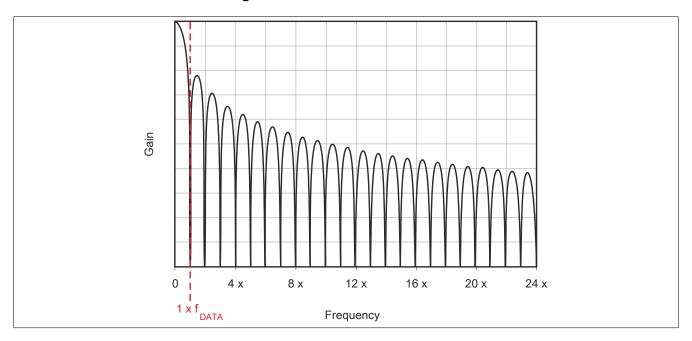
Figure 4: Connection example - Parallel connection of 2 full-bridge strain gauges

When connecting 3 or more full-bridge strain gauges in parallel, 2 lines must be connected together in an X20 terminal block.

3.7 Input circuit diagram



3.8 Filter characteristics of the sigma-delta A/D converter

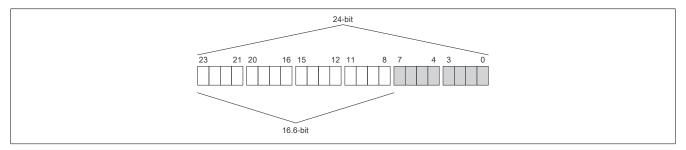


3.9 Effective resolution of the A/D converter

The A/D converter on the module provides a 24-bit measured value. The actual attainable noise-free resolution is always less than 24-bit, however. This "effective resolution" depends on the data rate and measurement range.

Example:

Based on the conversion method, a data rate of 2.5 Hz and a specified measurement range of 2 mV/V result in an effective resolution of 16.6 bits:



The low-order bits (grayed out) contain only noise instead of valid values and must therefore not be evaluated.

With "Function model 1 - Multiple sampling", only the highest 16 bits are made available.

3.10 Calculation example / Quantization

In a weighing application, the corresponding weight located on the connected load cell should be determined from the value derived from the module.

The characteristics of the strain gauge load cell are as follows:

Rated load: 1000 kgBridge factor: 4 mV/V

The value for the positive full-scale deflection at a specified rated load of 1000 kg is derived from the bridge factor of the strain gauge load cell (multiplication with the bridge supply voltage from the module):

$4 \text{ mV/V} \times 5.5 \text{ V} = 22 \text{ mV}$

With a simple Rule of Three calculation, the corresponding value can be calculated (as seen in the table) from weight to the converter value and vice versa. This simplified theoretical approach is only valid for an ideal measurement system. Calibration of the entire measurement system is recommended because not only the module, but particularly the strain gauge bridges exhibit tolerances (offset, gain). When taring, the gradient offset is recalculated and the gain of the linear equation is determined when normalized. In addition to the calculation displayed in the table, these calculations must also be carried out in the application.

24-bit value	of the module	Quantization	Corresponding weight
0x007F FFFF	0x007F FFFF 8,388,607		1000 kg
0x0000 0001	0x0000 0001 1		0.119 g
0x0000 20C3	0x0000 20C3 8387		1 kg
0x0001 0000	65536	171.9 μV	7.81 kg

The values for each LSB can be found in the technical data of the module under "Quantization" (1 LSB in reference to 16-bit and 1 LSB in reference to 24-bit).

3.11 Register description

3.11.1 General data points

In addition to the registers listed in the register description, the module also has other more general data points. These registers are not specific to the module but contain general information such as serial number and hardware version.

These general data points are listed in section "Additional information - General data points" of the X20 system user's manual.

3.11.2 Function model 0 - Standard

Register	Name	Data type	Read		Write	
			Cyclic Acyclic		Cyclic	Acyclic
2	StatusInput01	USINT	•			
4	AnalogInput01	DINT	•			
16	ConfigOutput01	USINT			•	
18	ConfigCycletime01	UINT				•
32	AdcClkFreqShift01 ¹⁾	USINT				•

¹⁾ Firmware version 8 / Upgrade 1.2.0.0 or later

3.11.3 Function model 1 - Multiple sampling

In this function model, the A/D converter is operated synchronously to X2X Link with a predefined A/D converter cycle time. The value is configurable as 50 or 100 μ s.

The module returns between 3 and 10 measured values per X2X cycle depending on the configuration. With an X2X cycle time of 400 µs and A/D converter cycle time of 50 µs, exactly 8 measurements are performed and the module can return 8 values (strain gauge value 01 to strain gauge value 08).

If a longer cycle time is used, the values returned correspond to the last measurements. If using an X2X cycle time that is not a whole number multiple of the A/D converter cycle time, then the conversion cannot be synchronized with X2X Link. In this case, the module outputs the invalid value 0x8000.

Example 1

If using an X2X cycle time of 800 μ s, it is possible to perform 16 measurements per X2X cycle if the A/D converter cycle time equals 50 μ s. The first 6 measured values are discarded; the last 10 measured values are provided by the module.

With a shorter X2X cycle time, the number of measured values should not exceed the number of measurements that can actually be made. All other measured values are invalid (0x8000). To minimize the load on X2X Link, it is possible to disable unneeded registers (see "Number of measured values").

Example 2

If using an X2X cycle time of 300 μ s, it is possible to perform 6 measurements per X2X cycle if the A/D converter cycle time equals 50 μ s. For this reason, only the first 6 registers are valid. The registers for the 7th through 10th measured value (AnalogInput07 to AnalogInput10) should be disabled by setting "Number of measured values" to "6 measured values" in the I/O configuration.

Register	Name	Data type	Read		Write	
			Cyclic Acyclic		Cyclic	Acyclic
2	StatusInput01	USINT	•			
1534 + N * 4	AnalogInput0N (N = 1 to 10)	INT	•			
1601	ConfigGain01_MultiSample	USINT			•	
1603	ConfigCycletime01_MultiSample	USINT				•

3.11.4 Function model 254 - Bus controller

In the "254 - Bus controller" function model, the module behaves as it does in "Function model 0 - Standard", with the exception that it is not synchronized to X2X Link even if synchronous mode is activated in register 3.11.5.3 "ConfigOutput01". Instead, the module behaves as if the set A/D converter cycle time is not a factor or multiple of the X2X cycle time and attempts to maintain the set A/D converter cycle time as precisely as possible.

Register	Name	Data type	Read		Write	
			Cyclic Acyclic		Cyclic	Acyclic
2	StatusInput01	USINT	•			
4	AnalogInput01	DINT	•			
16	ConfigOutput01	USINT			•	
18	ConfigCycletime01	UINT				•
32	AdcClkFreqShift011)	USINT				•

¹⁾ Firmware version 8 / Upgrade 1.2.0.0 or later

3.11.5 Register for the "0 - Standard" and "254 - Bus controller" function models

3.11.5.1 Module status

Name:

StatusInput01

The current state of the module is indicated in this register.

Data type	Value
USINT	See bit structure.

Bit structure:

Bit	Description	Value	Information
0	A/D converter value	0	Valid A/D converter value
		1	Invalid A/D converter value
1	Line monitoring	0	OK
		1	Open circuit
2	Only valid in synchronous mode	0	A/D converter runs synchronous to X2X Link
		1	A/D converter does not run synchronous to X2X Link
3 - 7	Reserved	-	

3.11.5.2 Strain gauge value

Name:

AnalogInput01

This register contains the raw value determined by the A/D converter for the full-bridge strain gauge with 24-bit resolution.

Data type	Value	Information
DINT	0xFF800001 to 0x007FFFFF	Valid range of values
	0x007FFFF	Overflow
	0xFF800001	Underflow
	0xFF800000	Invalid value

Effective resolution

In principle, the effective resolution of the A/D converter is dependent on the data rate and the measurement range (see 3.9 "Effective resolution of the A/D converter").

The following table shows how the effective resolution (in bits), or the RMS value range of the strain gauge value depend on the module configuration (data rate, measurement area).

	Measurement range							
	±16	±16 mV/V ±8 i		mV/V	mV/V ±4 m		±	2 mV/V
Data rate f _{DATA} [Hz]	Bits	Range of values	Bits	Range of values	Bits	Range of values	Bits	Range of values
2.5	21.3	±1,290,000	20.8	±912,000	19.7	±425,000	18.7	±212,000
5	20.7	±851,000	20.3	±645,000	19.3	±322,000	18.3	±161,000
10	20.4	±691,000	19.9	±490,000	18.9	±244,000	17.9	±122,000
15	20.1	±562,000	19.3	±320,000	18.7	±212,000	17.7	±106,000
25	19.7	±425,000	19.2	±301,000	18.5	±185,000	17.5	±92,000
30	19.6	±397,000	19.0	±262,000	18.1	±140,000	17.1	±72,000
50	19.4	±346,000	18.8	±230,000	17.9	±122,000	16.9	±61,000
60	19.3	±320,000	18.8	±230,000	17.8	±114,000	16.8	±57,000
100	19.1	±280,000	18.5	±185,000	17.4	±86,000	16.4	±43,000
500	18.0	±130,000	17.3	±80,000	16.3	±40,000	15.3	±20,000
1000	17.2	±75,000	16.5	±46,000	15.6	±25,000	14.6	±12,000
2000	16.6	±49,600	16.1	±35,000	15.3	±20,000	14.3	±10,000
3750	16.2	±37,600	15.7	±26,600	14.7	±13,000	13.7	±6,600
7500	15.8	±28,500	15.3	±20,200	14.4	±10,800	13.4	±5,400

Table 9: Effective resolution of the strain gauge value in bits for the measurement range 2 to 16 mV/V

		Measurement range									
	±256 mV/V		±128	±128 mV/V		±64 mV/V		±32 mV/V			
Data rate f _{DATA} [Hz]	Bits	Range of values	Bits	Range of values	Bits	Range of values	Bits	Range of values			
2.5	23	±4,194,000	22.6	±3,179,000	22.1	±2,248,000	21.7	±1,703,000			
5	22.3	±2,582,000	22.4	±2,767,000	21.9	±1,957,000	21.3	±1,291,000			
10	22.3	±2,582,000	22	±2,097,000	21.6	±1,589,000	21	±1,049,000			
15	22	±2,097,000	21.7	±1,703,000	21.3	±1,291,000	20.7	±852,000			
25	21.7	±1,703,000	21.4	±1,384,000	21.1	±1,124,000	20.5	±741,000			
30	21.8	±1,826,000	21.3	±1,291,000	20.8	±913,000	20.4	±692,000			
50	21.3	±1,291,000	21.1	±1,124,000	20.4	±692,000	19.9	±489,000			
60	21.3	±1,291,000	20.9	±978,000	20.5	±741,000	19.8	±456,000			
100	20.9	±978,000	20.7	±852,000	20.2	±602,000	19.6	±397,000			
500	20.1	±562,000	19.6	±397,000	19.1	±281,000	18.6	±199,000			
1000	19	±262,000	18.6	±199,000	18.1	±140,000	17.5	±93,000			
2000	18.5	±185,000	18.1	±140,000	17.8	±114,000	17	±66,000			
3750	18.1	±140,000	17.8	±114,000	17.3	±81,000	16.6	±50,000			
7500	17.7	±106,000	17.3	±81,000	16.9	±61,000	16.2	±38,000			

Table 10: Effective resolution of the strain gauge value in bits for the measurement range 32 to 256 mV/V

3.11.5.3 A/D converter configuration

Name:

ConfigOutput01

The data rate and measurement range of the A/D converter can be configured in this register.

Data type	Value
USINT	See bit structure.

Bit structure:

Bit	Description	Value	Information
0 - 3	Data rate f _{DATA} (samples per second):	0000	2.5
		0001	5
		0010	10
		0011	15
		0100	25
		0101	30
		0110	50
		0111	60
		1000	100
		1001	500
		1010	1000
		1011	2000
		1100	3750
		1101	7500
		1110	Synchronous mode ¹⁾
		1111	Reserved
4 - 6	Standard measurement range (bit 6 = 0)	000	16 mV/V
		001	8 mV/V
		010	4 mV/V
		011	2 mV/V
	Extended measurement range (bit 6 = 1) ²⁾	100	256 mV/V
		101	128 mV/V
		110	64 mV/V
		111	32 mV/V
7	Reserved	0	(must be 0)

¹⁾ A/D converter is operated synchronously with X2X Link if possible - firmware version 2 or later.

3.11.5.3.1 Synchronous mode

Beginning with firmware version 2, the analog/digital converter (A/D converter) of the module can be operated and read synchronously to X2X Link. Synchronous mode is enabled by selecting the respective operating mode in register *ConfigOutput01*. A time between 200 and 2000 µs must also be set in register *ConfigCycletime01*. If this time is a whole number factor or multiple of the configured cycle time of X2X Link, then the A/D converter is read synchronously to X2X Link.

Information:

The A/D converter cycle time must be ≥1/4 of the X2X cycle time!

Bit 2 in Module status is set (i.e. A/D converter not running synchronously)...

- ... If the configured A/D converter cycle time cannot be synchronized with X2X Link.
- · ... If the module is still in the settling phase.

Jitter, dead time and settling time:

Jitter	
A/D converter cycle times <1500 μs	Max. ±1 μs
A/D converter cycle times >1500 μs	Max. ±4 μs
X2X link dead time	50 μs + X2X cycle time 128
Settling time	
Firmware version ≤4	Max. 150 x A/D converter cycle time
Firmware version ≥5	150 x X2X cycle time

The settling time corresponds to the time needed until the A/D converter can be operated after enabling synchronous mode or following conversion of the A/D converter cycle time.

²⁾ Firmware version 4 or later

3.11.5.4 A/D converter cycle time

Name:

ConfigCycletime01

This register is only used in "Synchronous mode". If synchronous mode is enabled in the A/D converter configuration, then the module attempts to operate the A/D converter as synchronously as possible to X2X Link (based on the A/D converter cycle time set in this register). It is of course necessary for the X2X Link cycle time and the A/D converter cycle time to have a certain ratio. The following conditions must be observed:

- 1 A/D converter cycle time ≥ 1/4 X2X cycle time
- 2 A/D converter cycle time corresponds to a whole number factor or multiple of the X2X cycle time
- 3 A/D converter cycle time must be in the range 50 to 2000 μ s

Data type	Value
UINT	50 to 2000

3.11.5.5 A/D converter clock frequency shift

Name:

AdcClkFreqShift01

In rare cases, strain gauge modules connected to neighboring slots can influence one another. This can result in temporary, minimal deviations in measured values. This can only occur if the sigma-delta A/D converters on the neighboring strain gauge modules are operated at exactly the same clock frequency.

In most cases, these clock frequencies vary slightly due to part variances. When they are the same however, this register on the strain gauge module provides a safe way for an application to prevent this type of mutual influence.

Data type	Value
SINT	-128 to 127

This register can be used to vary the clock frequency in increments of 200 ppm. Setting values from -50 to 50 cover a range of -10000 ppm to 10000 ppm. This corresponds with -1% to 1%.

Values beyond this range will cause activation of a default mode. The frequency shift is derived from the last 2 digits of the serial number by the module firmware. This saves time that would otherwise be needed for programming, provided that the last two digits of the serial numbers on the neighboring modules are not the same

Register value	Frequency shift in ppm	Example of a sampling rate1)
127	((SerialNo. modulo 100) - 50) * (-200) ppm	Based on the serial number
51	((SerialNo. modulo 100) - 50) * (-200) ppm	Based on the serial number
50	10000	505
49	9800	504.9
2	400	500.2
1	200	500.1
0	0	500
-1	-200	499.9
-2	-400	499.8
-50	-10000	495
-51	((SerialNo. modulo 100) - 50) * (-200) ppm	Based on the serial number
-128	((SerialNo. modulo 100) - 50) * (-200) ppm	Based on the serial number

¹⁾ Nominal sampling rate of 500 samples per second

Important:

As shown in the table above, shifting the A/D converter clock frequency will equally shift the A/D converter sampling rate. Shifting the A/D converter clock frequency too much can cause problems with disturbance suppression particularly when a very specific sampling rate has been defined to suppress existing disturbances (e.g. 50 Hz to suppress the 50 Hz hum). See also 3.8 "Filter characteristics of the sigma-delta A/D converter".

It's situations like this where the option to manually shift the frequency in the I/O configuration or ASIOACC library should be utilized rather than relying on the default frequency shift that is based on the serial number.

A frequency shift like the one shown below would be sufficient to prevent modules from influencing one another and would not cause any noticeable difference to the filter characteristics.

Slot	1	2	3	4	5	6	
A/D converter clock frequency shift	0	2	-1	1	-2	0	

Information:

- This register has no effect in synchronous mode because the firmware regulates the A/D converter clock frequency in such a way that the A/D converter cycle is synchronous with the X2X cycle.
- When writing to this register using the ASIOACC library, only the lowest value byte of the written value is accepted. For example, the value 256 (=0x100) is identical to the value 0 (=0x00).

3.11.6 Register for "Function model 1 - Multiple sampling"

3.11.6.1 Module status

Name:

StatusInput01

The current state of the module is indicated in this register.

Data type	Value
USINT	See bit structure.

Bit structure:

Bit	Description	Value	Information
0	A/D converter values	0	Valid A/D converter value
		1	Invalid A/D converter value
1	Line monitoring	0	OK
		1	Open circuit An open circuit was found during at least one measurement in this X2X cycle. This bit is reset if all measurements are OK after correcting this error, i.e. it does not have to be acknowledged.
2	Synchronous mode	0	A/D converter runs synchronous to X2X Link
		1	A/D converter does not run synchronous to X2X Link
3 - 7	Reserved	-	

3.11.6.2 Strain gauge value - Multiple

Name:

AnalogInput01 to AnalogInput10

This register contains the raw value determined by the A/D converter for the full-bridge strain gauge with 16-bit resolution. The module returns between 3 and 10 measured values per X2X cycle depending on the configuration.

Effective resolution

In principle, the effective resolution of the A/D converter is dependent on the data rate and the measurement range (see 3.9 "Effective resolution of the A/D converter").

The following table shows how the effective resolution (in bits), or the RMS value range of the strain gauge value depend on the module configuration (data rate, measurement area).

Measurement range									
±16	±16 mV/V ±8 mV/V ±4 mV/V ±2 mV/V								
Bits	Range of values	Bits	Range of values	Bits	Range of values	Bits	Range of values		
15.4	22,000	14.6	12,000	13.8	7,000	12.8	4,000		

Table 11: Effective resolution of the strain gauge value in bits for the measurement range 2 to 16 mV/V

Measurement range								
±256	±256 mV/V ±128 mV/V ±64 mV/V ±32 mV/V						mV/V	
Bits	Range of values	Bits	Range of values	Bits	Range of values	Bits	Range of values	
17.1	70,000	16.7	53,000	16.4	43,000	15.9	31,000	

Table 12: Effective resolution of the strain gauge value in bits for the measurement range 32 to 256 mV/V

3.11.6.3 A/D converter configuration

Name:

ConfigGain01 MultiSample

The measurement range for the A/D converter can be configured in this register.

Data type	Value
USINT	See bit structure.

Bit structure:

Bit	Description	Value	Information
0 - 2	Standard measurement range (bit 2 = 0)	000	16 mV/V
		001	8 mV/V
		010	4 mV/V
		011	2 mV/V
	Extended measurement range (bit 2 = 1) ¹⁾	100	256 mV/V
		101	128 mV/V
		110	64 mV/V
		111	32 mV/V
3 - 7	Reserved	0	(must be 0)

Starting with Firmware Version 4. In the standard measurement range (2 to 16 mV/V), open-circuit detection works reliably at all adjustable data rates. In
the extended measurement range (32 to 256 mV/V), open circuit detection does not work reliably (because of the variable input impedance of the amplifier
in relation to the set data rate).

3.11.6.4 A/D converter cycle time

Name:

ConfigCycletime01 MultiSample

The A/D converter cycle time can be configured in this register.

In order for multiple sampling to work, the X2X cycle time must be divisible by the A/D converter cycle time (i.e. result in a whole number).

Data type	Value	Information
USINT	0	50 μs (default)
	1	100 μs
	2 to 255	Reserved

3.11.6.5 Number of measured values

If the X2X cycle time is too short, then bot all 10 measurements can be performed. To reduce the load on X2X Link, it makes sense to only transfer as many values as measurements that can be made. This is why it is possible to configure the number of measured values to be transferred (see 3.11.3 "Function model 1 - Multiple sampling").

Example: A/D converter cycle time 50 μ s

X2X cycle time	Number of measured values to be transferred
250 µs	5
300 μs	6
350 µs	7
400 µs	8
450 μs	9
≥500 µs	10

Example: A/D converter cycle time 100 μs

X2X cycle time	Number of measured values to be transferred
300 μs	3
400 μs	4
500 μs	5
600 μs	6
700 µs	7
800 μs	8
900 μs	9
≥1 ms	10

3.11.7 Minimum cycle time

The minimum cycle time defines how far the bus cycle can be reduced without communication errors occurring. Note that very fast cycles decrease the idle time available for handling monitoring, diagnostics and acyclic commands.

Minimum cycle time	
	250 μs

3.11.8 Minimum I/O update time

The minimum I/O update time defines how far the bus cycle can be reduced while still allowing an I/O update to take place in each cycle.

There is no limitation or basic dependency on the bus cycle time. In function model "0 - Standard", the I/O update time is defined using registers 3.11.5.3 "ConfigOutput01" and 3.11.5.4 "ConfigCycletime01".

Depending on the setting in register 3.11.5.4 "ConfigCycletime01", the I/O update time in function model "1 - Multiple sampling" is 50 or 100 µs.